## Notice of References Cited

Application/Control No. 10/626,011	Reexamination	Applicant(s)/Patent Under Reexamination DE WAAL, ABRAHAM B.		
Examiner	Art Unit			
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## II S PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0197739 A1	10-2003	Bauer, Jason M.	345/800
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	D	US-			
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## FOREIGN PATENT DOCUMENTS

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